

<b>Notice of References Cited</b>	Application/Control No. 10/584,064		Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
	Examiner DAVID CZEKAJ		Art Unit 2621	Page 1 of 1

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*	C	US-7,204,592	04-2007	O'Donnell et al.	353/7
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#### NON-PATENT DOCUMENTS

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